

<b>Notice of References Cited</b>		Application/Control No. 10/518,915	Applicant(s)/Patent Under Reexamination YANO ET AL.	
		Examiner Amy L. Clark	Art Unit 1655	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
*	B	US-4,707,354	11-1987	Garlen et al.	424/47
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	S	JP 2002128651 A	05-2002	Japan	SEI et al.	
	T	JP 07145067 A	06-1995	Japan	ANDRE-JEAN et al.	

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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